

<b>Notice of References Cited</b>	Application/Control No. 10/790,653		Applicant(s)/Patent Under Reexamination LEE ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0220910 A1	11-2004	Zang et al.	707/003
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